

# Search Notes



Application/Control No.

10/646,307

Examiner

Sin J. Lee

Applicant(s)/Patent under  
Reexamination

BABICH ET AL.

Art Unit

1752

## SEARCHED

| Class | Subclass | Date | Examiner |
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## INTERFERENCE SEARCHED

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## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

|   | DATE           | EXMR |
|---|----------------|------|
| ① EAST TEXT Search<br>in USPAT & US-PGPUB<br>(See Search History<br>Printout) | 10-13<br>-2005 | SJL  |
| Structure Search on<br>the formula shown<br>on pg. 4 of present<br>spec.      | 9-28<br>-05    | SJL  |
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